

### K3530-VB Datasheet

# N-Channel 800V (D-S) Super Junction Power MOSFET

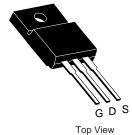
PRODUCT SUMMA	RY			
V <sub>DS</sub> (V)	800	)		
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	1.2		
Q <sub>g</sub> (Max.) (nC)	200			
Q <sub>gs</sub> (nC)	24			
Q <sub>gd</sub> (nC)	110			
Configuration	Sing	le		

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC









PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		$V_{DS}$	800	V	
Gate-Source Voltage		$V_{GS}$	± 30	<b>7</b>	
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 ^{\circ}\text{C}$	I_	5		
Continuous Drain Guirent	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	3.9	A	
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	21		
Linear Derating Factor			1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	770	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	7.8	Α	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N·m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V<sub>DD</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 23 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 7.8 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  7.8 A, dl/dt  $\leq$  140 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  600 V, T<sub>J</sub>  $\leq$  150 °C.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65	

<b>SPECIFICATIONS</b> ( $T_J = 25  ^{\circ}\text{C},  \text{u}$	riiess otrierwi	ise notea)					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> = 250 μA	800	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> :	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 800 V, V <sub>GS</sub> = 0 V V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	100 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 3.7 \text{ Ab}$	-	1.2	-	Ω
Forward Transconductance	9fs		= 100 V, I <sub>D</sub> = 3.7 A <sup>b</sup>	5.6	-	-	S
Dynamic					L		l
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	3100	-	
Output Capacitance	C <sub>oss</sub>			-	800	-	рF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	f = 1.0 MHz, see fig. 5		490	-	
Total Gate Charge	Qg		V <sub>GS</sub> = 10 V I <sub>D</sub> = 3.8 A, V <sub>DS</sub> = 400 V,	-	-	200	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	24	
Gate-Drain Charge	Q <sub>gd</sub>	see fig. 6 and 13 <sup>b</sup>		-	-	110	1
Turn-On Delay Time	t <sub>d(on)</sub>			-	19	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 400 \text{ V, } I_{D} = 3.8 \text{ A,}$ $R_{g} = 6.2 \Omega, R_{D} = 52 \Omega$ see fig. $10^{b}$		-	38	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	120	-	
Fall Time	t <sub>f</sub>			-	39	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 3.8 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A, dl/dt = 100 A/μs <sup>b</sup>		-	650	980	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	5.7	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	on is dor	ninated b	by L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

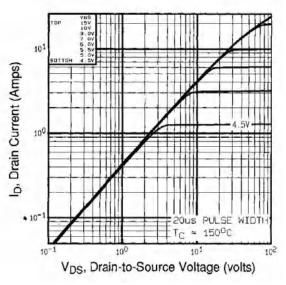


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

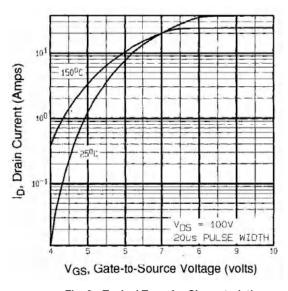


Fig. 3 - Typical Transfer Characteristics

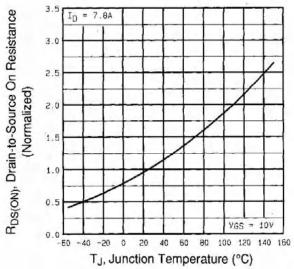


Fig. 4 - Normalized On-Resistance vs. Temperature



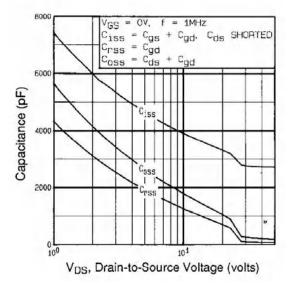


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

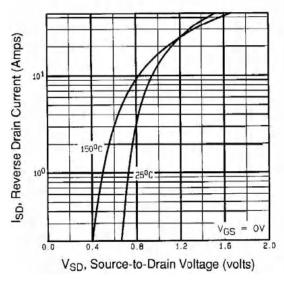


Fig. 7 - Typical Source-Drain Diode Forward Voltage

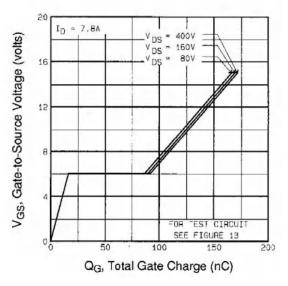


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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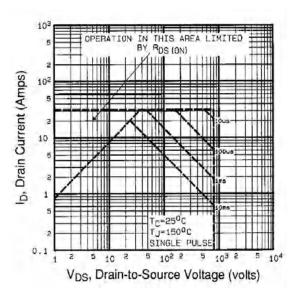


Fig. 8 - Maximum Safe Operating Area



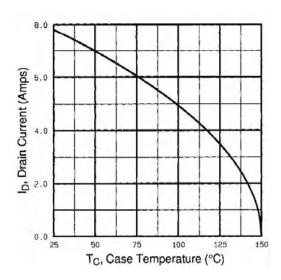


Fig. 9 - Maximum Drain Current vs. Case Temperature

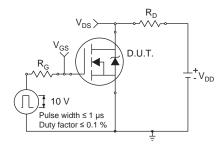


Fig. 10a - Switching Time Test Circuit

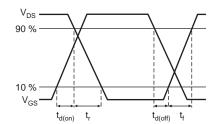


Fig. 10b - Switching Time Waveforms

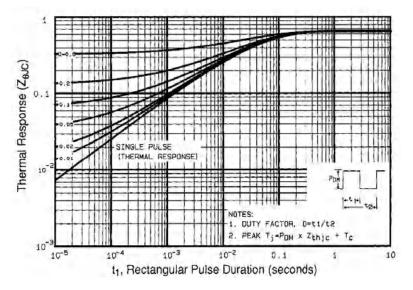


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



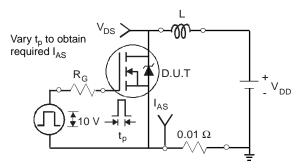


Fig. 12a - Unclamped Inductive Test Circuit

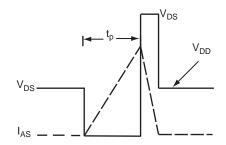


Fig. 12b - Unclamped Inductive Waveforms

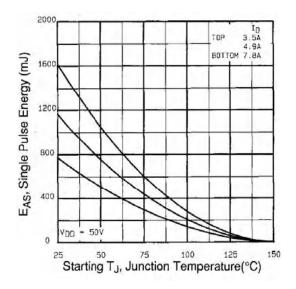


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

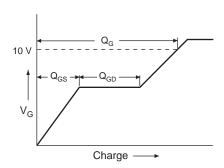


Fig. 13a - Basic Gate Charge Waveform

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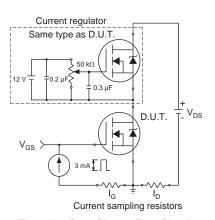
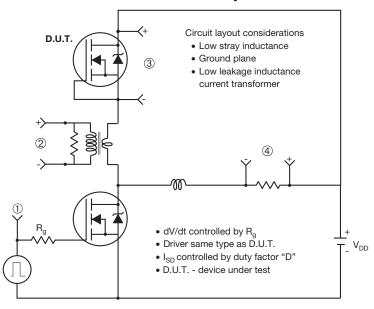


Fig. 13b - Gate Charge Test Circuit



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#### Peak Diode Recovery dV/dt Test Circuit



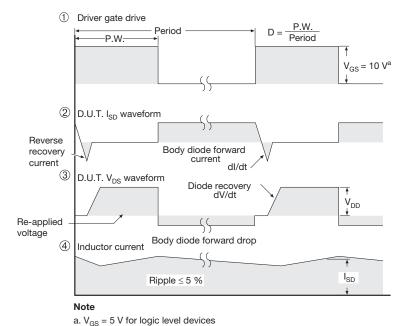
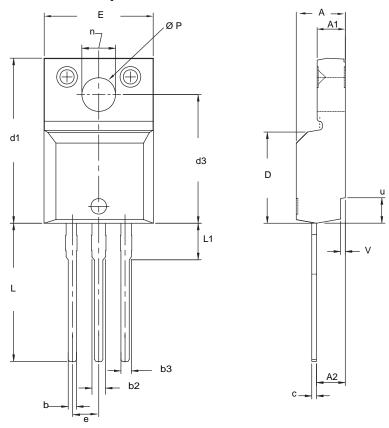


Fig. 14 - For N-Channel



## **TO-220 FULLPAK (HIGH VOLTAGE)**



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54 BSC		0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

DWG: 5972

#### Notes

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.
   No chipping or package damage.



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